Search Notes				

Application/Control No.	Applicant(s)/Patent und Reexamination	ier
10/750,566	KESHAVARZI ET AL.	
Examiner	Art Unit	
Thinh T. Nguyen	2818	

SEARCHED				
Class	Subclass	Date	Examiner	
438	270	8/16/2005	TTN	
438	705	8/16/2005	TTN	
438	723	8/17/2005	TTN	
438	743	8/17/2005	TTN	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
EAST	PUB	10/18/05	TM
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SEAF (INCLUDING S	RCH NOTES SEARCH STRATEGY	)
•	DATE	EXMR
EAST	8/16/2005	TTN
EAST	8/17/2005	TTN
EAST	10/18/05	מנד